

## FEATURES

- Member of the Texas Instruments Widebus™ Family
- Operates From 1.65 V to 3.6 V
- Max  $t_{pd}$  of 5.2 ns at 3.3 V
- $\pm 24$ -mA Output Drive at 3.3 V
- All Outputs Have Equivalent 26- $\Omega$  Series Resistors, So No External Resistors Are Required
- Bus Hold on Data Inputs Eliminates the Need for External Pullup/Pulldown Resistors
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- ESD Protection Exceeds JESD 22
  - 2000-V Human-Body Model (A114-A)
  - 200-V Machine Model (A115-A)

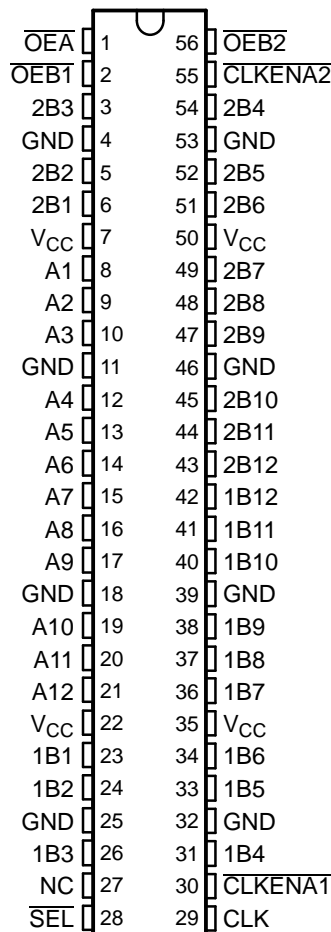
## DESCRIPTION/ORDERING INFORMATION

This 12-bit to 24-bit registered bus exchanger is designed for 1.65-V to 3.6-V  $V_{CC}$  operation.

The SN74ALVCHR16269A is used in applications in which two ports must be multiplexed onto, or demultiplexed from, a single port. It is particularly suitable as an interface between synchronous DRAMs and high-speed microprocessors.

Data is stored in the internal B-port registers on the low-to-high transition of the clock (CLK) input, when the appropriate clock-enable (CLKENA) inputs are low. Proper control of these inputs allows two sequential 12-bit words to be presented as a 24-bit word on the B port. For data transfer in the B-to-A direction, a single storage register is provided. The select ( $\overline{SEL}$ ) line selects 1B or 2B data for the A outputs. The register on the A output permits the fastest possible data transfer, thus extending the period during which the data is valid on the bus. The control terminals are registered so that all transactions are synchronous with CLK. Data flow is controlled by the active-low output enables ( $\overline{OEA}$ ,  $\overline{OEB1}$ , and  $\overline{OEB2}$ ).

DGG, DGV, OR DL PACKAGE  
(TOP VIEW)



NC – No internal connection

## ORDERING INFORMATION

$T_A$	PACKAGE <sup>(1)</sup>		ORDERABLE PART NUMBER	TOP-SIDE MARKING
-40°C to 85°C	SSOP – DL	Tube	SN74ALVCHR16269AL	ALVCHR16269A
		Tape and reel	SN74ALVCHR16269ALR	
	TSSOP – DGG	Tape and reel	SN74ALVCHR16269AGR	ALVCHR16269A
	TVSOP – DGV	Tape and reel	SN74ALVCHR16269AVR	VR269A

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at [www.ti.com/sc/package](http://www.ti.com/sc/package).



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# SN74ALVCHR16269A

## 12-BIT TO 24-BIT REGISTERED BUS EXCHANGER WITH 3-STATE OUTPUTS

SCES0500–AUGUST 1995–REVISED SEPTEMBER 2004

### DESCRIPTION/ORDERING INFORMATION (CONTINUED)

To ensure the high-impedance state during power up or power down, a clock pulse should be applied as soon as possible, and  $\overline{OE}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver. Due to  $\overline{OE}$  being routed through a register, the active state of the outputs cannot be determined prior to the arrival of the first clock pulse.

Active bus-hold circuitry holds unused or undriven inputs at a valid logic state. Use of pullup or pulldown resistors with the bus-hold circuitry is not recommended.

All outputs are designed to sink up to 12 mA and include equivalent 26- $\Omega$  resistors to reduce overshoot and undershoot.

### FUNCTION TABLES

#### OUTPUT ENABLE

INPUTS			OUTPUTS	
CLK	$\overline{OE}A$	$\overline{OE}B$	A	1B, 2B
$\uparrow$	H	H	Z	Z
$\uparrow$	H	L	Z	Active
$\uparrow$	L	H	Active	Z
$\uparrow$	L	L	Active	Active

#### A-TO-B STORAGE ( $\overline{OE}B = L$ )

INPUTS			OUTPUTS	
$\overline{CLKENA1}$	$\overline{CLKENA2}$	CLK	A	1B 2B
L	H	$\uparrow$	L	L $2B_0^{(1)}$
L	H	$\uparrow$	H	H $2B_0^{(1)}$
L	L	$\uparrow$	L	L L
L	L	$\uparrow$	H	H H
H	L	$\uparrow$	L	$1B_0^{(1)}$ L
H	L	$\uparrow$	H	$1B_0^{(1)}$ H
H	H	X	X	$1B_0^{(1)}$ $2B_0^{(1)}$

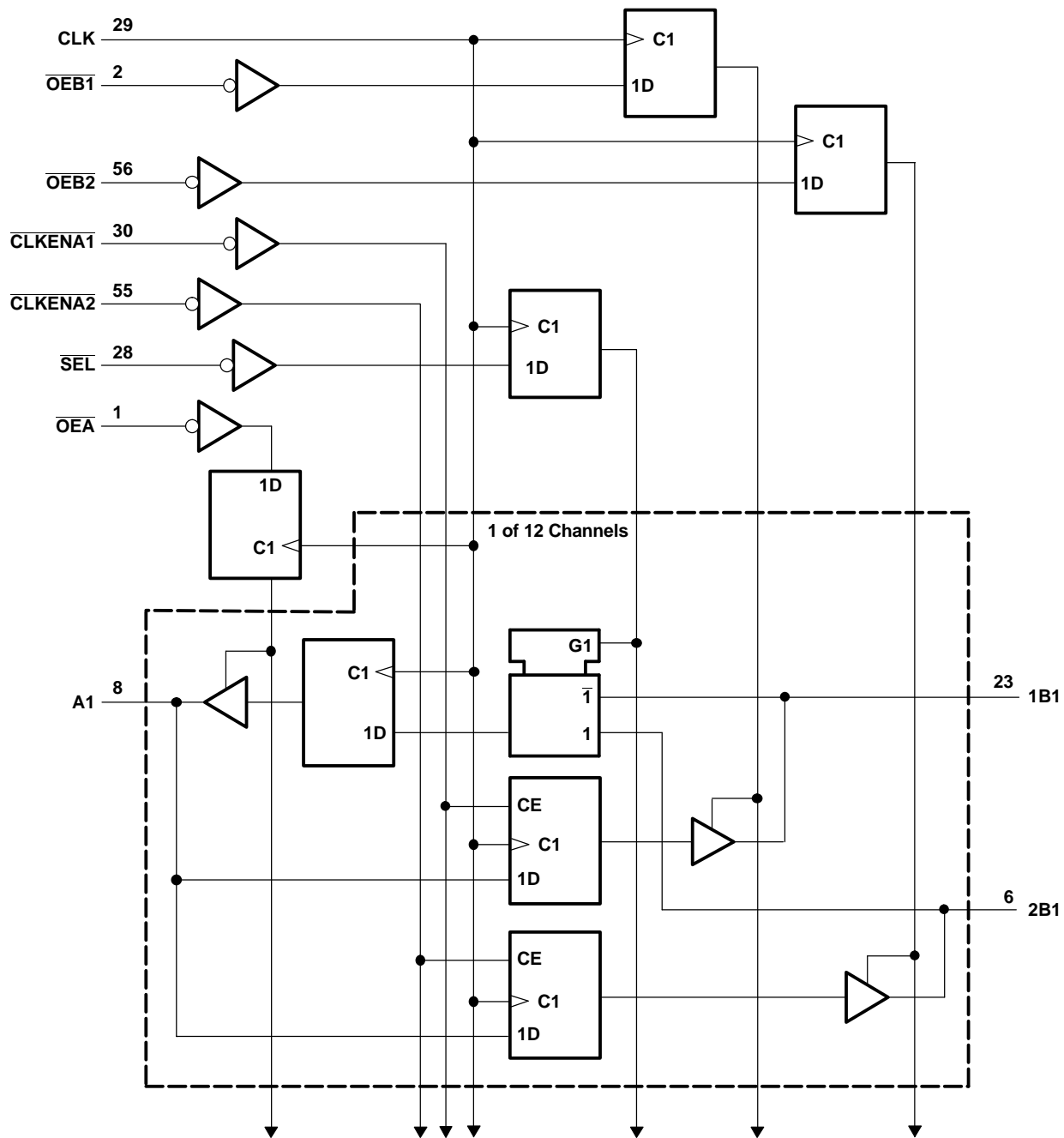
- (1) Output level before the indicated steady-state input conditions were established

#### B-TO-A STORAGE ( $\overline{OE}A = L$ )

INPUTS				OUTPUT A
CLK	$\overline{SEL}$	1B	2B	
X	H	X	X	$A_0^{(1)}$
X	L	X	X	$A_0^{(1)}$
$\uparrow$	H	L	X	L
$\uparrow$	H	H	X	H
$\uparrow$	L	X	L	L
$\uparrow$	L	X	H	H

- (1) Output level before the indicated steady-state input conditions were established

**LOGIC DIAGRAM (POSITIVE LOGIC)**



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## 12-BIT TO 24-BIT REGISTERED BUS EXCHANGER WITH 3-STATE OUTPUTS

SCES0500–AUGUST 1995–REVISED SEPTEMBER 2004

### ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

		MIN	MAX	UNIT
$V_{CC}$	Supply voltage range	-0.5	4.6	V
$V_I$	Input voltage range	Except I/O ports <sup>(2)</sup>	-0.5	4.6
		I/O ports <sup>(2)(3)</sup>	-0.5	$V_{CC} + 0.5$
$V_O$	Output voltage range <sup>(2)(3)</sup>		$V_{CC} + 0.5$	V
$I_{IK}$	Input clamp current	$V_I < 0$	-50	mA
$I_{OK}$	Output clamp current	$V_O < 0$	-50	mA
$I_O$	Continuous output current		±50	mA
	Continuous current through each $V_{CC}$ or GND		±100	mA
$\theta_{JA}$	Package thermal impedance <sup>(4)</sup>	DGG package	64	°C/W
		DGV package	48	
		DL package	56	
$T_{stg}$	Storage temperature range	-65	150	°C

- (1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.
- (3) This value is limited to 4.6 V, maximum.
- (4) The package thermal impedance is calculated in accordance with JESD 51-7.

### RECOMMENDED OPERATING CONDITIONS<sup>(1)</sup>

		MIN	MAX	UNIT
$V_{CC}$	Supply voltage	1.65	3.6	V
$V_{IH}$	High-level input voltage	$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$	$0.65 \times V_{CC}$	V
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	1.7	
		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	2	
$V_{IL}$	Low-level input voltage	$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$	$0.35 \times V_{CC}$	V
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	0.7	
		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	0.8	
$V_I$	Input voltage	0	$V_{CC}$	V
$V_O$	Output voltage	0	$V_{CC}$	V
$I_{OH}$	High-level output current	$V_{CC} = 1.65 \text{ V}$	-2	mA
		$V_{CC} = 2.3 \text{ V}$	-6	
		$V_{CC} = 2.7 \text{ V}$	-8	
		$V_{CC} = 3 \text{ V}$	-12	
$I_{OL}$	Low-level output current	$V_{CC} = 1.65 \text{ V}$	2	mA
		$V_{CC} = 2.3 \text{ V}$	6	
		$V_{CC} = 2.7 \text{ V}$	8	
		$V_{CC} = 3 \text{ V}$	12	
$\Delta t/\Delta v$	Input transition rise or fall rate		10	ns/V
$T_A$	Operating free-air temperature	-40	85	°C

- (1) All unused control inputs of the device must be held at  $V_{CC}$  or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

## ELECTRICAL CHARACTERISTICS

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V <sub>CC</sub>	MIN	TYP <sup>(1)</sup>	MAX	UNIT
V <sub>OH</sub>	I <sub>OH</sub> = -100 µA	1.65 V to 3.6 V	V <sub>CC</sub> - 0.2			V
	I <sub>OH</sub> = -2 mA	1.65 V	1.2			
	I <sub>OH</sub> = -4 mA	2.3 V	1.9			
	I <sub>OH</sub> = -6 mA	2.3 V	1.7			
		3 V	2.4			
	I <sub>OH</sub> = -8 mA	2.7 V	2			
	I <sub>OH</sub> = -12 mA	3 V	2			
V <sub>OL</sub>	I <sub>OL</sub> = 100 µA	1.65 V to 3.6 V	0.2			V
	I <sub>OL</sub> = 2 mA	1.65 V	0.45			
	I <sub>OL</sub> = 4 mA	2.3 V	0.4			
	I <sub>OL</sub> = 6 mA	2.3 V	0.55			
		3 V	0.55			
	I <sub>OL</sub> = 8 mA	2.7 V	0.6			
	I <sub>OL</sub> = 12 mA	3 V	0.8			
I <sub>I</sub>	V <sub>I</sub> = V <sub>CC</sub> or GND	3.6 V			±5	µA
I <sub>I(hold)</sub>	V <sub>I</sub> = 0.58 V	1.65 V	25			µA
	V <sub>I</sub> = 1.07 V		-25			
	V <sub>I</sub> = 0.7 V	2.3 V	45			
	V <sub>I</sub> = 1.7 V		-45			
	V <sub>I</sub> = 0.8 V	3 V	75			
	V <sub>I</sub> = 2 V		-75			
	V <sub>I</sub> = 0 to 3.6 V <sup>(2)</sup>	3.6 V			±500	
I <sub>OZ</sub> <sup>(3)</sup>	V <sub>O</sub> = V <sub>CC</sub> or GND	3.6 V			±10	µA
I <sub>CC</sub>	V <sub>I</sub> = V <sub>CC</sub> or GND, I <sub>O</sub> = 0	3.6 V			40	µA
ΔI <sub>CC</sub>	One input at V <sub>CC</sub> - 0.6 V, Other inputs at V <sub>CC</sub> or GND	3 V to 3.6 V			750	µA
C <sub>i</sub>	Control inputs	V <sub>I</sub> = V <sub>CC</sub> or GND	3.3 V		5	pF
C <sub>io</sub>	A or B ports	V <sub>O</sub> = V <sub>CC</sub> or GND	3.3 V		8.5	pF

(1) All typical values are at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C.

(2) This is the bus-hold maximum dynamic current. It is the minimum overdrive current required to switch the input from one state to another.

(3) For I/O ports, the parameter I<sub>OZ</sub> includes the input leakage current.

# SN74ALVCHR16269A

## 12-BIT TO 24-BIT REGISTERED BUS EXCHANGER WITH 3-STATE OUTPUTS

SCES0500–AUGUST 1995–REVISED SEPTEMBER 2004

### TIMING REQUIREMENTS

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

		V <sub>CC</sub> = 1.8 V		V <sub>CC</sub> = 2.5 V ± 0.2 V		V <sub>CC</sub> = 2.7 V		V <sub>CC</sub> = 3.3 V ± 0.3 V		UNIT		
		MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX			
f <sub>clock</sub>	Clock frequency	(1)		95		115		135		MHz		
t <sub>w</sub>	Pulse duration, CLK high or low	(1)		5.2		4.3		3.3		ns		
t <sub>su</sub>	Setup time	A data before CLK↑		(1)		1.4		1.4		1		ns
		B data before CLK↑		(1)		1.6		1.5		1.1		
		SEL before CLK↑		(1)		0.8		1.1		1.3		
		CLKENA1 or CLKENA2 before CLK↑		(1)		0.8		1		0.8		
		OE before CLK↑		(1)		1.7		1.6		1.2		
t <sub>h</sub>	Hold time	A data after CLK↑		(1)		0.9		0.9		1.2		ns
		B data after CLK↑		(1)		0.8		0.6		1		
		SEL after CLK↑		(1)		1.1		0.8		1.7		
		CLKENA1 or CLKENA2 after CLK↑		(1)		1.4		1		1.6		
		OE after CLK↑		(1)		0.9		0.8		1.2		

(1) This information was not available at the time of publication.

### SWITCHING CHARACTERISTICS

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$V_{CC} = 1.8\text{ V}$		$V_{CC} = 2.5\text{ V} \pm 0.2\text{ V}$		$V_{CC} = 2.7\text{ V}$		$V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}$		UNIT
			MIN	TYP	MIN	MAX	MIN	MAX	MIN	MAX	
$f_{\text{max}}$			(1)		95		115		135		MHz
$t_{\text{pd}}$	CLK	B	(1)		2.3	7.7	6.9		2.2	5.8	ns
		A	(1)		1.9	6.4	5.8		2	5.2	
$t_{\text{en}}$	CLK	B	(1)		2.5	7.7	6.9		2.3	5.8	ns
		A	(1)		2.2	6.7	6		2.1	5.3	
$t_{\text{dis}}$	CLK	B	(1)		3.3	8.1	6.7		2.4	6	ns
		A	(1)		2.7	8	6.2		2.1	6	

(1) This information was not available at the time of publication.

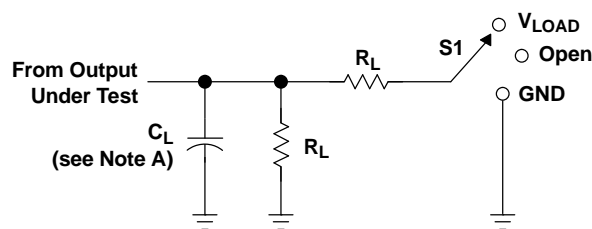
### OPERATING CHARACTERISTICS

$T_A = 25^\circ\text{C}$

PARAMETER		TEST CONDITIONS	$V_{CC} = 1.8\text{ V}$	$V_{CC} = 2.5\text{ V}$	$V_{CC} = 3.3\text{ V}$	UNIT
			TYP	TYP	TYP	
$C_{\text{pd}}$	Outputs enabled	$C_L = 0, f = 10\text{ MHz}$	(1)	142	172	pF
	Outputs disabled		(1)	115	129	

(1) This information was not available at the time of publication.

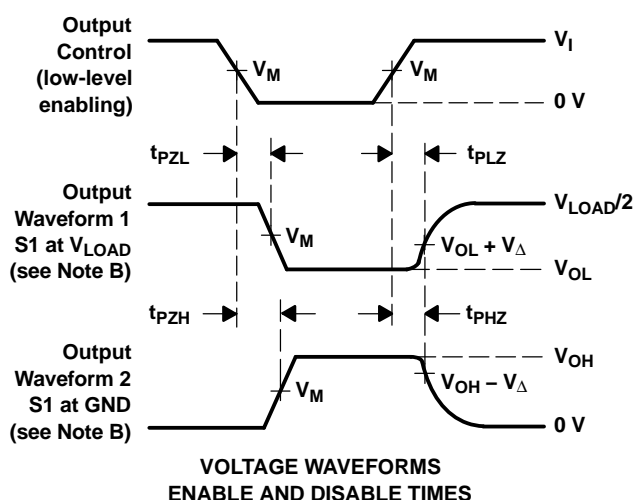
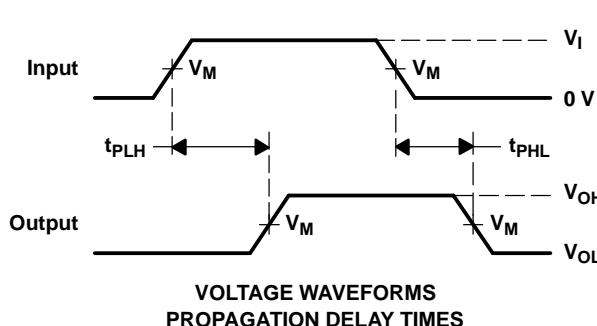
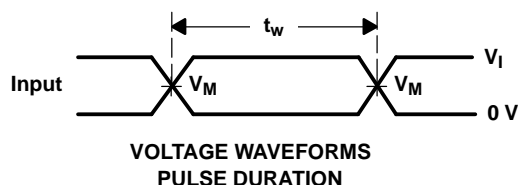
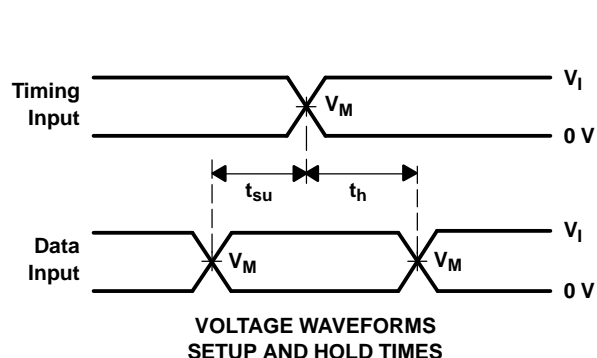
## PARAMETER MEASUREMENT INFORMATION



LOAD CIRCUIT

TEST	S1
$t_{pd}$ $t_{PLZ}/t_{PZH}$ $t_{PHZ}/t_{PZH}$	Open $V_{LOAD}$ GND

$V_{CC}$	INPUT		$V_M$	$V_{LOAD}$	$C_L$	$R_L$	$V_{\Delta}$
	$V_I$	$t_r/t_f$					
$1.8\text{ V} \pm 0.15\text{ V}$	$V_{CC}$	$\leq 2\text{ ns}$	$V_{CC}/2$	$2 \times V_{CC}$	30 pF	1 k $\Omega$	0.15 V
$2.5\text{ V} \pm 0.2\text{ V}$	$V_{CC}$	$\leq 2\text{ ns}$	$V_{CC}/2$	$2 \times V_{CC}$	30 pF	500 $\Omega$	0.15 V
2.7 V	2.7 V	$\leq 2.5\text{ ns}$	1.5 V	6 V	50 pF	500 $\Omega$	0.3 V
$3.3\text{ V} \pm 0.3\text{ V}$	2.7 V	$\leq 2.5\text{ ns}$	1.5 V	6 V	50 pF	500 $\Omega$	0.3 V



- NOTES:
- $C_L$  includes probe and jig capacitance.
  - Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
  - All input pulses are supplied by generators having the following characteristics:  $PRR \leq 10\text{ MHz}$ ,  $Z_O = 50\ \Omega$ .
  - The outputs are measured one at a time, with one transition per measurement.
  - $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
  - $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
  - $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .
  - All parameters and waveforms are not applicable to all devices.

Figure 1. Load Circuit and Voltage Waveforms

## DGV (R-PDSO-G\*\*)

## PLASTIC SMALL-OUTLINE

24 PINS SHOWN



- NOTES: A. All linear dimensions are in millimeters.  
 B. This drawing is subject to change without notice.  
 C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.  
 D. Falls within JEDEC: 24/48 Pins – MO-153  
 14/16/20/56 Pins – MO-194



DL (R-PDSO-G\*\*)

PLASTIC SMALL-OUTLINE PACKAGE

48 PINS SHOWN



- NOTES: A. All linear dimensions are in inches (millimeters).  
 B. This drawing is subject to change without notice.  
 C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).  
 D. Falls within JEDEC MO-118

## DGG (R-PDSO-G\*\*)

## PLASTIC SMALL-OUTLINE PACKAGE

48 PINS SHOWN



- NOTES: A. All linear dimensions are in millimeters.  
 B. This drawing is subject to change without notice.  
 C. Body dimensions do not include mold protrusion not to exceed 0,15.  
 D. Falls within JEDEC MO-153

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